

Notice of References Cited	Application/Control No. 10/595,595		Applicant(s)/Patent Under Reexamination MIYAHARA ET AL.	
	Examiner John P. Sheehan		Art Unit 1793	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	C	US-2003/0047706 A1	03-2003	Mitani et al.	252/62.54
*	D	US-6,342,557 B1	01-2002	Suzuki et al.	524/432
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	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

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